TOSHIBA Bipolar Digital Integrated Circuit Silicon Monolithic

TD62164APG, TD62164AFG

4ch High-Current Darlington Sink Driver

The TD62164APG and TD62164AFG are high-voltage, high-current darlington drivers comprised of four NPN darlington pairs.

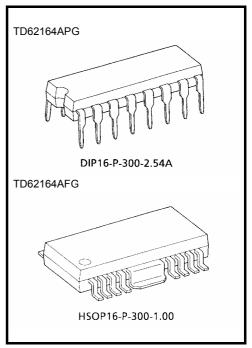
All units feature integral clamp diodes for switching inductive loads

Applications include relay, hammer, lamp and stepping motor drivers.

Please observe the thermal condition for using.

Features

- Output current (single output) 700 mA (max)
- High sustaining voltage output 50 V (min)
- · Output clamp diodes
- Input compatible with TTL and 5-V CMOS
- GND and SUB terminal heat sink
- Package type-APG: DIP-16 pin
- Package type-AFG: HSOP-16 pin

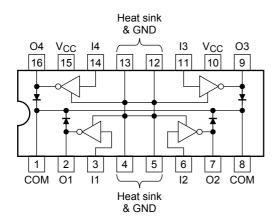


Weight

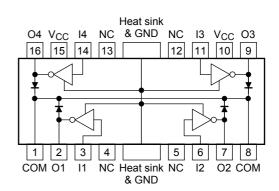
DIP16-P-300-2.54A : 1.11 g (typ.) HSOP16-P-300-1.00 : 0.50 g (typ.)

Pin Connection (top view)

TD62164APG

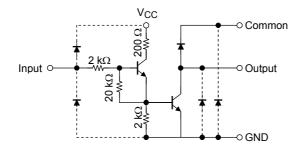


AD62164AFG





Schematics (each driver)



Note: The input and output parasitic diodes cannot be used as clamp diodes.

Maximum Ratings (Ta = 25°C)

Characteristics		Symbol	Rating	Unit
Supply voltage		V_{CC}	−0.5 to 17	V
Output sustaining voltage		V _{CE} (SUS)	-0.5 to 50	V
Output current		lout	700	mA/ch
Input current		I _{IN}	50	mA
Input voltage		V _{IN}	17	V
Clamp diode reverse voltage		V _R	50	V
Clamp diode forward current		lF	700	mA
Operating temperature	APG	D-	1.47/2.7 (Note 1)	W
	AFG	P _D	0.9/1.4 (Note 2)	VV
Operating temperature		T _{opr}	-40 to 85	°C
Storage temperature		T _{stg}	-55 to 150	°C

Note 1: On glass epoxy PCB ($50 \times 50 \times 1.6$ mm Cu 50%) Note 2: On glass epoxy PCB ($60 \times 60 \times 1.6$ mm Cu 30%)

Recommended Operating Conditions ($Ta = -40 \text{ to } 85^{\circ}\text{C}$)

Characteristics		Symbol	Condition		Min	Тур.	Max	Unit	
Supply voltage		V _{CC}			4.5	_	5.5	V	
Output sustaining voltage		V _{CE} (SUS)			0	_	50	V	
			DC 1 circuit, Ta = 25°C		0	_	570		
Output current	APG	Іоит	T _{pw} = 25 ms	Duty = 10%	0	_	570	mA/ch	
			4 circuits	Duty = 50%	0		570		
	AFG		Ta = 85°C	Duty = 10%	0	_	570		
			$T_j = 120^{\circ}C$	Duty = 50%	0	_	480		
		V _{IN}			0	_	15	V	
Input voltage	Output on V _{IN}	Vincent	I _{OUT} = 500 mA	h _{FE} = 150	10.0	_	15	V	
		V _{IN} (ON)		$h_{FE} = 2000$	2.4	_	15		
	Output off	V _{IN (OFF)}			0	_	0.4		
Input current		I _{IN}			0	_	20	mA	
Clamp diode reverse voltage		V _R			_	_	50	V	
Clamp diode forward current		lF			_	_	500	mA	
Power dissipation	APG	P _D	Ta = 85°C	(Note 1)	_	_	1.4	W	
	AFG		Ta = 85°C	(Note 2)	_	_	0.7		

Note 1: On glass epoxy PCB ($50 \times 50 \times 1.6$ mm Cu 50%)

Note 2: On glass epoxy PCB ($60 \times 30 \times 1.6$ mm Cu 30%)

Electrical Characteristics (Ta = 25°C)

Characteristics		Symbol	Test Circuit	Test Condition	Min	Тур.	Max	Unit	
Output leakage current		ICEX	1	V _{CE} = 50 V, Ta = 25°C	_	_	50	^	
				V _{CE} = 50 V, Ta = 85°C	_	_	100	μΑ	
Collector-emitter saturation voltage		V _{CE} (sat)	2	I _{OUT} = 500 mA, V _{CC} = 5 V	_	_	0.8	· v	
				I _{OUT} = 200 mA, V _{CC} = 5 V	_	_	0.45		
DC current trans	fer ratio	h _{FE}	2	V _{CE} = 2 V, I _{OUT} = 500 mA	2000	_	_		
Input voltage (Output on)		VIN (ON)	3	I _{OUT} = 500 mA, h _{FE} = 150	7.0	_	10.0	V	
				I _{OUT} = 500 mA, h _{FE} = 2000	1.8	_	2.4		
Clamp diode reverse current		I _R	4	V _R = 50 V, Ta = 25	_	_	50	^	
				V _R = 50 V, Ta = 85°C	_	_	100	μА	
Clamp diode forward voltage		VF	5	I _F = 500 mA	_	_	2.0	V	
Supply current	Output on	I _{CC} (ON)	6	V _{CC} = 5.5 V, V _{IN} = 2.4 V	_	35	40	mA/ch	
	Output off	I _{CC} (OFF)		V _{CC} = 5.5 V, V _{IN} = 0.4 V	_	_	10	μА	
Input capacitance		C _{IN}	_	V _{IN} = 0 V, f = 1 MHz	_	15	_	pF	
Turn-on delay		t _{ON}	7	$V_{OUT} = 50 \text{ V}, R_L = 72 \Omega$ $V_{CC} = 5.0 \text{ V}, C_L = 15 \text{ pF}$	_	0.2	0.4	μs	
Turn-off delay		toff			_	4.0	8.0		

Test Circuit

1. I_{CEX}

Open Common

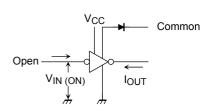
2. hfe, VCE (sat)

$$I_{IN} \xrightarrow{V_{CC}} Common$$

$$I_{OUT} \xrightarrow{V_{CE (sat)}, V_{OUT}}$$

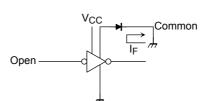
$$h_{FE} = \frac{I_{OUT}}{I_{IN}} \xrightarrow{m}$$

3. V_{IN (ON)}



4. I_R

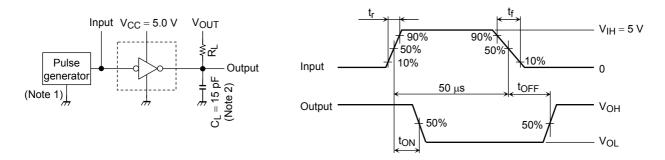
5. V_F



6. ICC (ON), ICC (OFF)



7. ton, toff



Note 1: Pulse width 50 μs , duty cycle 10%, output impedance 50 Ω , $t_f \le 5$ ns, $t_f \le 10$ ns.

Note 2: C_L includes probe and jig capacitance.

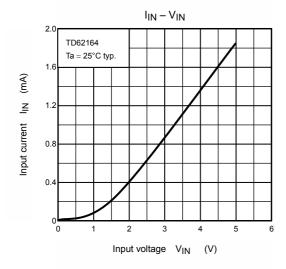
Precautions for Using

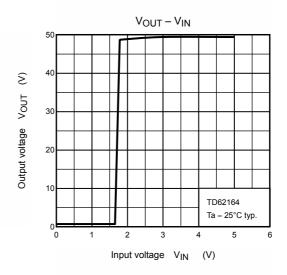
This IC does not include built-in protection circuits for excess current or overvoltage.

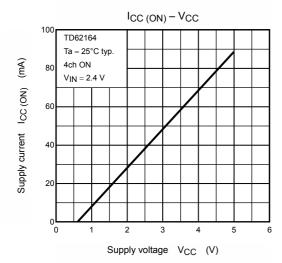
If this IC is subjected to excess current or overvoltage, it may be destroyed.

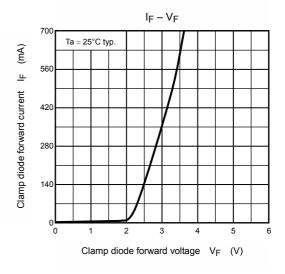
Hence, the utmost care must be taken when systems which incorporate this IC are designed.

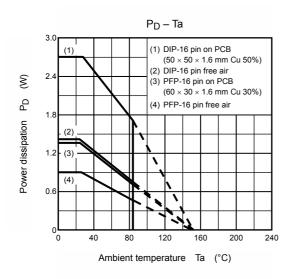
Utmost care is necessary in the design of the output line, V_{CC} , COMMON and GND line since IC may be destroyed due to short–circuit between outputs, air contamination fault, or fault by improper grounding.



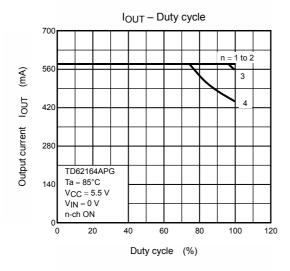


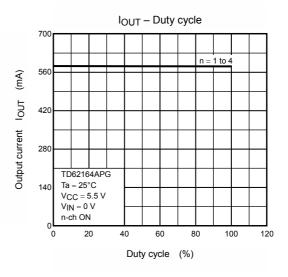


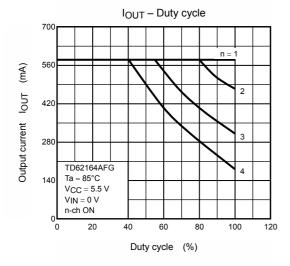


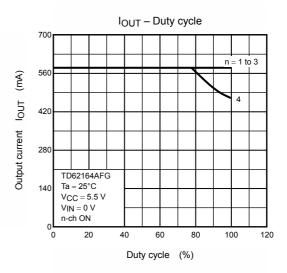


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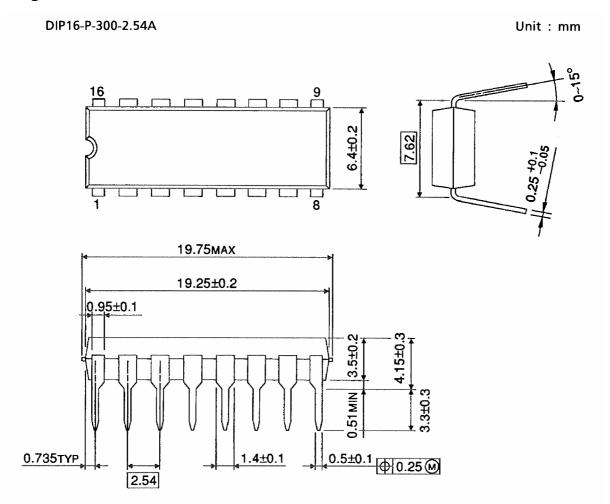








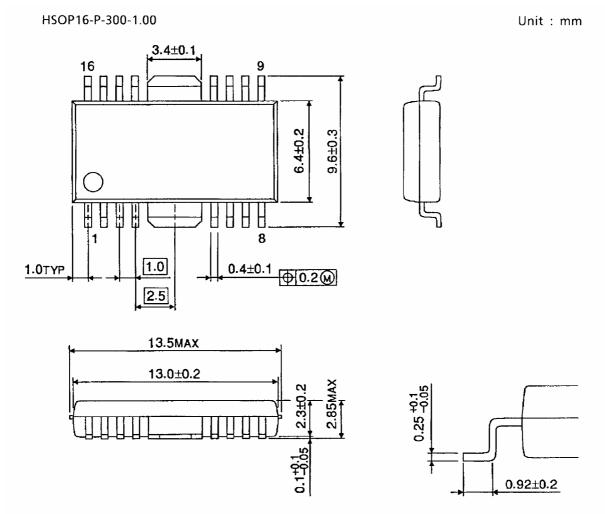
Package Dimensions



Weight: 1.11 g (typ.)



Package Dimensions



Weight: 0.50 g (typ.)

About solderability, following conditions were confirmed

- Solderability
 - (1) Use of Sn-63Pb solder Bath
 - · solder bath temperature = 230°C
 - · dipping time = 5 seconds
 - · the number of times = once
 - use of R-type flux
 - (2) Use of Sn-3.0Ag-0.5Cu solder Bath
 - · solder bath temperature = 245°C
 - · dipping time = 5 seconds
 - · the number of times = once
 - · use of R-type flux

Handbook" etc..

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